SUNSTAR传感与控制 http://www.sensor-ic.com/ TEL:0755-83376549 FAX:0755-83376182 E-MAIL:szss20@163.com



General Description

The MAX1460 implements a revolutionary concept in signal conditioning, where the output of its 16-bit analog-to-digital converter (ADC) is digitally corrected over the specified temperature range. This feature can be readily exploited by automotive, industrial, and medical market segments, in applications such as sensors and smart batteries. Digital correction is provided by an internal digital signal processor (DSP) and on-chip 128-bit EEPROM containing user-programmed calibration coefficients. The conditioned output is available as a 12-bit digital word and as a ratiometric (proportional to the supply voltage) analog voltage using an on-board 12-bit digital-to-analog converter (DAC). The uncommitted op amp can be used to filter the analog output, or implement a 2-wire, 4–20mA transmitter.

The analog front end includes a 2-bit programmablegain amplifier (PGA) and a 3-bit coarse-offset (CO) DAC, which condition the sensor's output. This coarsely corrected signal is digitized by a 16-bit ADC. The DSP uses the digitized sensor signal, the temperature sensor, and correction coefficients stored in the internal EEPROM to produce the conditioned output.

Multiple or batch manufacturing of sensors is supported with a completely digital test interface. Built-in testability features on the MAX1460 result in the integration of three traditional sensor-manufacturing operations into one automated process:

- Pretest: Data acquisition of sensor performance under the control of a host test computer.
- Calibration and Compensation: Computation and storage of calibration and compensation coefficients determined from transducer pretest data.
- Final Test Operation: Verification of transducer calibration and compensation, without removal from the pretest socket.

The MAX1460 evaluation kit (EV kit) allows fast evaluation and prototyping, using a piezoresistive transducer (PRT) and a Windows[®]-based PC. The user-friendly EV kit simplifies small-volume prototyping; it is not necessary to fully understand the test-system interface, the calibration algorithm, or many other details to evaluate the MAX1460 with a particular sensor. Simply plug the PRT into the EV kit, plug the EV kit into a PC parallel port, connect the sensor to an excitation source (such as a pressure controller), and run the MAX1460 EV kit software. An oven is required for thermal compensation.

Functional Diagram appears at end of data sheet.

Pin Configuration appears at end of data sheet.

Windows is a registered trademark of Microsoft Corp.

M AXIM

_Features

- ♦ Low-Noise, 400µA Single-Chip Sensor Signal Conditioning
- High-Precision Front End Resolves Less than 1µV of Differential Input Signal
- On-Chip DSP and EEPROM Provide Digital Correction of Sensor Errors
- 16-Bit Signal Path Compensates Sensor Offset and Sensitivity and Associated Temperature Coefficients
- ♦ 12-Bit Parallel Digital Output
- Analog Output
- Compensates a Wide Range of Sensor Sensitivity and Offset
- Single-Shot Automated Compensation Algorithm—No Iteration Required
- Built-In Temperature Sensor
- Three-State, 5-Wire Serial Interface Supports High-Volume Manufacturing

Applications

Application Hand-Held Instruments Piezoresistive Pressure and Acceleration Transducers and Transmitters Industrial Pressure Sensors and 4–20mA Transmitters Smart Battery Charge Systems Weigh Scales and Strain-Gauge Measurement Flow Meters Dive Computers and Liquid-Level Sensing Hydraulic Systems

Automotive Systems

Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
MAX1460CCM	0°C to +70°C	48 TQFP

Customization

Maxim can customize the MAX1460 for unique requirements. With a dedicated cell library of more than 90 sensor-specific functional blocks, Maxim can quickly provide customized MAX1460 solutions, including customized microcode for unusual sensor characteristics. Contact Maxim for further information.

For free samples & the latest literature: http://www.maxim-ic.com, or phone 1-800-998-8800. For small orders, phone 1-800-835-8769. SUNSTAR首动化 http://www.sensor-ic.com/ TEL: 0755-83376489 FAX:0755-83376182 E-MAIL:szss20@163.com

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{DD} to V_{SS}.....-0.3V to +6V All Other Pins(V_{SS} - 0.3V) to (V_{DD} + 0.3V) Short-Circuit Duration, All OutputsContinuous Continuous Power Dissipation (T_A = +70°C) 48-Pin TQFP (derate 12.5mW/°C above +70°C).....1000mW

Operating Temperature Range	0°C to +70°C
Storage Temperature Range	65°C to +160°C
Lead Temperature (soldering, 10sec)	+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

 $(V_{DD} = +5V, V_{SS} = 0, f_{XIN} = 2MHz, T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS	
GENERAL CHARACTERISTICS	1					1	
Supply Voltage (Note 1)	V _{DD}	During operation	4.75	5.0	5.25	V	
Supply Current (Note 2)	IDD	Continuous conversion		400	700	μA	
Throughput Rate				15		Hz	
ANALOG INPUT							
Input Impedance	RIN			1.0		MΩ	
Gain Temperature Coefficient (TC)				±40		ppm/°C	
Input-Referred Offset TC				±1200		nV/°C	
Common-Mode Rejection Ratio	CMRR	From V _{SS} to V _{DD}		90		dB	
PGA AND COARSE-OFFSET DA	AC (Notes 3	8, 4)					
		PGA gain code = 00	43	46	49		
PGA Gain		PGA gain code = 01	59	61	64		
		PGA gain code = 10	74	77	80	- V/V	
		PGA gain code = 11	90	93	96		
		CO-DAC code = 111	-164	-149	-134	-	
		CO-DAC code = 110	-111	-96	-81		
		CO-DAC code = 101	-62	-47	-32		
		CO-DAC code = 100	-10	5	20		
Coarse Offset		CO-DAC code = 000	-20	-5	10	% V _{DD}	
		CO-DAC code = 001	32	47	62	-	
		CO-DAC code = 010	81	96	111		
		CO-DAC code = 011	134	149	164		
ADC (Notes 3, 4)	1					1	
Resolution				16		Bits	
Integral Nonlinearity (Note 5)	INL	PGA gain code = 00, CO-DAC code = 000		0.006		%	
Input-Referred Noise				1700		nV _{RMS}	
Output-Referred Noise		5k Ω input impedance		2		LSB _{RMS}	
TEMPERATURE SENSOR (Note	6)						
Resolution				260		LSB/°C	
Linearity		$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$		1.3		°C	



ELECTRICAL CHARACTERISTICS (continued)

 $(V_{DD} = +5V, V_{SS} = 0, f_{XIN} = 2MHz, T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN T	YP MAX	UNITS
OUTPUT DAC (Note 7)					
DAC Resolution			1	2	bits
Integral Nonlinearity	INL			1	LSB
Differential Nonlinearity	DNL		C	.5	LSB
UNCOMMITTED OP AMP					
Op Amp Supply Current			1(00	μΑ
Input Common-Mode Range	CMR		V _{SS} + 1.3	V _{DD} - 1.0	V
Open-Loop Gain	Av		6	0	dB
Offset Voltage (as unity-gain follower)	V _{OS}	V _{IN} = 2.5V (no load)	-30	+30	mV
Output Voltage Swing		No load	V _{SS} + 0.05	V _{DD} - 0.05	V
Output Current Range		$V_{OUT} = (V_{SS} + 0.2V)$ to $(V_{DD} - 0.2V)$	±5	600	μA
DIGITAL INPUTS: START, CS1,	CS2, SDIO	(Note 8), RESET, XIN (Note 9), TEST			
Input High Voltage	VIH		4.0		V
Input Low Voltage	VIL			1.0	V
Input Hysteresis	V _{HYST}		1	.0	V
Input Leakage	lin	$V_{IN} = 0 \text{ or } V_{DD}$		±10	μA
Input Capacitance	CIN	(Note 10)		50.0	рF
DIGITAL OUTPUTS: D[110]					
Output Voltage Low	Vol	I _{SINK} = 500μA		0.5	V
Output Voltage High	Voh	ISOURCE = 500µA	4.5		V
Three-State Leakage Current	١L	CS = 0		±10	μA
Three-State Output Capacitance	COUT	CS = 0 (Note 10)		50.0	рF
DIGITAL OUTPUTS: SDIO (Note	8) , SDO, E	OC, OUT			
Output Voltage Low	Vol	I _{SINK} = 500µA	C	.3	V
Output Voltage High	V _{OH}	I _{SOURCE} = 500μA 4.7		.7	V
Three-State Leakage Current	١L	CS = 0	±	10	μA
Three-State Output Capacitance	Соит	CS = 0 (Note 10)		50.0	рF

Note 1: EEPROM programming requires a minimum $V_{DD} = 4.75V$. I_{DD} may exceed its limits during this time.

Note 2: This value does not include the sensor or load current. This value does include the uncommitted op amp current. Note that the MAX1460 will convert continuously if REPEAT MODE is set in the EEPROM.

Note 3: See the Analog Front-End, including PGA, Coarse Offset DAC, ADC, and Temperature Sensor sections.

Note 4: The signal input to the ADC is the output of the PGA plus the output of the CO-DAC. The reference to the ADC is V_{DD}. The plus full-scale input to the ADC is +V_{DD} and the minus full-scale input to the ADC is -V_{DD}. This specification shows the contribution of the CO-DAC to the ADC input.

Note 5: See Figure 2 for ADC outputs between +0.8500 to -0.8500.

Note 6: The sensor and the MAX1460 must always be at the same temperature during calibration and use.

Note 7: The Output DAC is specified using the external lowpass filter (Figure 8).

Note 8: SDIO is an input/output digital pin. It is only enabled as a digital output pin when the MAX1460 receives from the test system the commands 8 hex or A hex (Table 4).

Note 9: XIN is a digital input pin only when the TEST pin is high.

Note 10: Guaranteed by design. Not subject to production testing.

MAX1460

PIN	NAME	FUNCTION
1, 2, 12, 13, 18, 19, 31, 32, 36, 41–45	N.C.	No Connection. Not internally connected.
3	AGND	Analog Ground. Connect to V_DD and V_SS using 10k Ω resistors (see Functional Diagram).
4	START	Optional conversion start input signal, used for extending sensor warm-up time. Internally pulled to V_{DD} with a 1M Ω (typical) resistor.
5	I.C.	Internally Connected. Leave unconnected.
6	D6	Parallel Digital Output - bit 6
7	D7	Parallel Digital Output - bit 7
8	D8	Parallel Digital Output - bit 8
9	D9	Parallel Digital Output - bit 9
10	D10	Parallel Digital Output - bit 10
11	D11	Parallel Digital Output - bit 11 (MSB)
14, 37, 38	V _{DD}	Positive Supply Voltage Input. Connect a 0.1 μ F bypass capacitor from V _{DD} to V _{SS} . Pins 14, 37, and 38 must all be connected to the positive power supply on the PCB.
15	V _{SS}	Negative Supply Input
16, 17	CS1, CS2	Chip-Select Input. The MAX1460 is selected when CS1 and CS2 are both high. When either CS1 or CS2 is low, all digital outputs are high impedance and all digital inputs are ignored. CS1 and CS2 are internally pulled high to V_{DD} with a 1M Ω (typical) resistor.
20	SDIO	Serial Data Input/Output. Used only during programming/testing, when the TEST pin is high. The test system sends commands to the MAX1460 through SDIO. The MAX1460 returns the current instruction ROM address and data being executed by the DSP to the test system. SDIO is internally pulled to V _{SS} with a 1M Ω (typical) resistor. SDIO goes high impedance when either CS1 or CS2 is low and remains in this state until the test system initiates conversion.
21	SDO	Serial Data Output. Used only during programming/testing. SDO allows the test system to monitor the DSP registers. The MAX1460 returns to the test system results of the DSP current instruction. SDO is high impedance when TEST is low.
22	RESET	Reset Input. When TEST is high, a low-to-high transition on $\overline{\text{RESET}}$ enables the MAX1460 to accept commands from the test system. This input is ignored when TEST is low. Internally pulled high to V _{DD} with a 1M Ω (typical) resistor.
23	EOC	End of Conversion Output. A high-to-low transition of the EOC pulse can be used to latch the Parallel Digital Output (pins D[110]).
24	D0	Parallel Digital Output - bit 0 (LSB)
25	D1	Parallel Digital Output - bit 1
26	D2	Parallel Digital Output - bit 2

Pin Description

Pin Description (continued)

PIN	NAME	FUNCTION				
27	D3	Parallel Digital Output - bit 3				
28	D4	Parallel Digital Output - bit 4				
29	D5	Parallel Digital Output - bit 5				
30	OUT	Output DAC. The bitstream on OUT, when externally filtered, creates a ratiometric analog output age. OUT is proportional to the 12-bit parallel digital output.				
33	AMPOUT	General-Purpose Operational Amplifier Output				
34	AMP+	Noninverting Input of General-Purpose Operational Amplifier				
35	AMP-	Inverting Input of General-Purpose Operational Amplifier				
39	XOUT	Internal Oscillator Output. Connect a 2MHz ceramic resonator (Murata CST200) or crystal from XOUT to XIN.				
40	XIN	Internal Oscillator Input. When TEST is high, this pin must be driven by the test system with a 2MHz, 50% duty cycle clock signal. The resonator does not need to be disconnected in test mode.				
46	INP	Positive Sensor Input. Input impedance is typically > $1M\Omega$. Rail-to-Rail [®] input range.				
47	TEST	Test/Program Mode Enable Input. When high, enables the MAX1460 programming/testing operations. Internally pulled to V_{SS} with a 1M Ω (typical) resistor.				
48	INM	Negative Sensor Input. Input impedance is typically > $1M\Omega$. Rail-to-rail input range.				

Rail-to-Rail is a registered trademark of Nippon Motorola, Ltd.

M/X/W

MAX1460

Detailed Description

The main functions of the MAX1460 include:

- Analog Front End: Includes PGA, coarse-offset DAC, ADC, and temperature sensor
- Test System Interface: Writes calibration coefficients to the DSP registers and EEPROM
- Test System Interface: observes the DSP operation.

The sensor signal enters the MAX1460 and is adjusted for coarse gain and offset by the analog front end. Five bits in the configuration register set the coarse-offset DAC and the coarse gain of the PGA (Tables 1 and 2). These bits must be properly configured for the optimum dynamic range of the ADC. The digitized sensor signal is stored in a read-only DSP register.

The on-chip temperature sensor also has a 3-bit coarse-offset DAC that places the temperature signal in the ADC operating range. Digitized temperature is also stored in a read-only DSP register. The DSP uses the digitized sensor, the temperature signals, and the correction coefficients to calculate the compensated and corrected output.

The MAX1460 supports an automated production environment, where a test system communicates with a batch of MAX1460s and controls temperature and sen-

Table 1. Nominal PGA Gain Settings

PGA SETTING	PGA-1	PGA-0	NOMINAL GAIN (V/V)
0	0	0	46
1	0	1	61
2	1	0	77
3	1	1	93

Table 2. Typical Coarse Offset DAC Settings

sor excitation. The three-state digital outputs on the MAX1460 allow parallel connection of transducers, so that all five serial interface lines (XIN, TEST, RESET, SDIO, and SDO) can be shared. The test system selects an individual transducer using CS1 and CS2. The test system must vary the sensor's input and temperature, calculate the correction coefficients for each unit, load the coefficients into the MAX1460 nonvolatile EEPROM, and test the resulting compensation.

The MAX1460 DSP implements the following characteristic equation:

$$D = Gain (1 + G_1T + G_2T^2)$$
$$(Signal + Of_0 + Of_1T + Of_2T^2) + D_{OFF}$$

where Gain corrects the sensor's sensitivity, G₁ and G₂ correct for Gain-TC, T and Signal are the digitized outputs of the analog front end, Ofo corrects the sensor's offset, Of₁ and Of₂ correct the Offset-TC, and DOFF is the output offset pedestal.

The test system can write the calibration coefficients into the MAX1460 EEPROM or write to the DSP registers directly. The MAX1460 can begin a conversion using either the EEPROM contents or the register contents. When the test system issues commands, the MAX1460 is a serially controlled slave device.

The test system observes the MAX1460 DSP operation in order to acquire the temperature and signal ADC results, to verify the calibration coefficients, and to get the output D. The MAX1460 places the contents of several important DSP registers on the serial interface after the tester issues a Start Conversion command.

After calibration, compensation, and final test, the MAX1460 is adapted to its sensor and the pair can be removed from the test system. Use the resulting trans-

CO SETTING	CO-S	CO-1	CO-0	% V _{DD} (at ADC input)	PGA SETTING 0 (mV RTI) (V _{DD} = 5V)	PGA SETTING 1 (mV RTI) (V _{DD} = 5V)	PGA SETTING 2 (mV RTI) (V _{DD} = 5V)	PGA SETTING 3 (mV RTI) (V _{DD} = 5V)
-3	1	1	1	-149	-162	-122	-97	-80
-2	1	1	0	-96	-104	-79	-62	-52
-1	1	0	1	-47	-51	-39	-31	-25
-0	1	0	0	5	5	4	3	3
+0	0	0	0	-5	-5	-4	-3	-3
+1	0	0	1	47	51	39	31	25
+2	0	1	0	96	104	79	62	52
+3	0	1	1	149	162	122	97	80





ducer by applying power and the START signal. Latch the 12-bit parallel digital output using the EOC pulse. The maximum conversion rate of the MAX1460 is 15Hz, using a 2MHz resonator. If an analog output is desired, build a simple lowpass filter using the OUT pin, the uncommitted op amp, and a few discrete components (Figure 8).

Analog Front End, Including PGA, Coarse Offset DAC, ADC, and Temperature Sensor

Before the sensor signal is digitized, it must be gained and coarse-offset corrected to maximize the ADC dynamic range. There are 2 bits (four possible settings) in the configuration register for the PGA gain, and 3 bits (eight possible settings) for the CO DAC. The flowchart (Figure 1) shows a procedure for finding the optimum

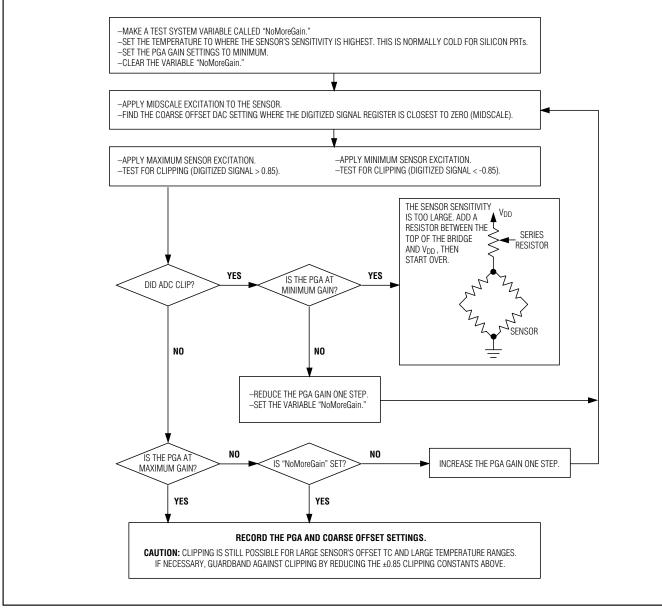


Figure 1. Flowchart for Determining PGA and CO Settings

/N/IXI/N

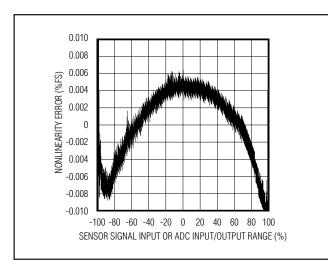


Figure 2a. Analog Front-End INL (typical)

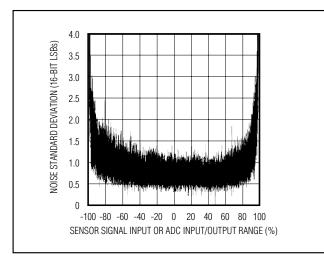


Figure 2c. Analog Front-End Noise Standard Deviation of the Samples (typical)

analog front-end settings when the sensor's characteristics are unknown. Use the tabulated values (Tables 1 and 2) if the peak sensor excursions are known. See the *Test System Interface* section for details on writing these analog front-end bits.

The PGA gain and the CO are very stable, but are not accurate. Manufacturing variances on the gain and offset of the MAX1460 analog front-end superposition the residual sensor errors, and are later removed during final calibration.

For example, suppose the sensor's sensitivity is +10mV/V with an offset of -12mV/V. Let the supply volt-

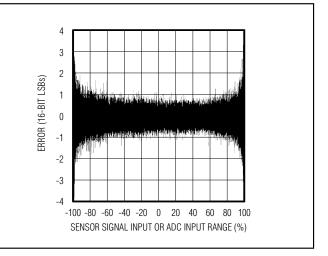


Figure 2b. Analog Front-End Differential Nonlinearity (DNL) (typical)

age be +5V. The full scale (-FS) output of the sensor is then +5V(-12mV/V) = -60mV; +FS is then +5V (-12mV/V + 10mV/V) = -10mV. Following through the flowchart, the PGA gain setting is +3 (gain = 93V/V) and the CO correction setting is +1 (+25mV RTI) - (Referred-to Input). The coarsely corrected -FS input to the ADC is (-60mV + 25mV)93 = -3.255V. The +FS input to the ADC is (-10mV + 25mV)93 = +1.395V. The input range of the ADC is \pm VDD. Thus the maximum and minimum digitized sensor signals become -3.255 / 5 = -0.651 and +1.395 / 5 = +0.279.

Notice that the bridge multiplies the signal by V_{DD} and the ADC divides the signal by V_{DD}. Thus, the system is ratiometric and not dependent on the DC value of V_{DD}. The ADC output clips to ± 1.0 when input values exceed \pm V_{DD}. The best signal-to-noise ratio (SNR) is achieved when the ADC input is within $\pm 85\%$ of V_{DD} (Figure 2).

The MAX1460 includes an internal temperature-sensing bridge allowing the MAX1460 temperature to be used as a proxy for the sensor temperature. For this reason, the MAX1460 must be mounted in thermal proximity to the sensor. The output of the temperature-sensing bridge is also corrected by a 3-bit coarse-offset DAC and processed by the ADC. The selection of the Temperature Sensor Offset (TSO) bits in the configuration register should be made so that the digitized temperature signal is as close to 0.0 as possible at midscale temperature. This is done to maximize the dynamic range of the thermal-calibration coefficients (Table 3).



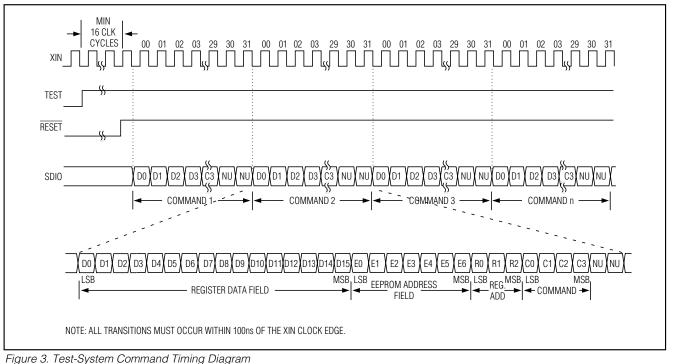


Table 3. Temperature Sensor Offset (TSO) Settings

TSO SETTING	TSO-2	TSO-1	TSO-0	TEMPERATURE BRIDGE OFFSET
0	0	0	0	Maximum
1	0	0	1	-
2	0	1	0	-
3	0	1	1	_
4	1	0	0	-
5	1	0	1	_
6	1	1	0	_
7	1	1	1	Minimum

Test-System Interface: Writing Calibration Coefficients to the DSP Registers and EEPROM

To make the MAX1460 respond to commands from the test system, raise the TEST pin and drive XIN with a 2MHz clock signal. It is not necessary to remove the resonator. RESET must be low for at least 16 clock cycles to initialize the MAX1460. Then, a rising transi-

tion on RESET begins a 32-bit serial transfer of the testsystem command word through SDIO. The test system transitions SDIO on falling edges of the XIN clock; the MAX1460 latches data is on the rising edge (Figure 3).

The 32-bit command word generated by the test-system is divided into four fields (Figure 3). The 4-bit command field is interpreted in Table 4. The other fields are usually ignored, except that command 1 hex uses the two register fields, and command 2 hex requires an EEPROM address. The command word fields are:

- Register Data Field: Holds the calibration coefficients to be written into the MAX1460 16-bit registers
- EEPROM Address Field: Holds the hexadecimal address of the EEPROM bit to be set (from 00 hex to 7F hex)
- Register Address Field: Contains the address of the register (0 to 7) where the calibration coefficient is to be written
- Command Field: Instructs the MAX1460 to take a particular action (Table 4)

MAX1460

M/X/W

Table 4. Test System Commands

COMMAND	HEX CODE	C3	C2	C1	C 0
Write a calibration coefficient into a DSP register.	1 hex	0	0	0	1
Block-Erase the entire EEPROM (writes "0" to all 128 bits).	4 hex	0	1	0	0
Write "1" to a single EEPROM bit.	2 hex	0	0	1	0
NOOP (NO-OPeration)	0 hex	0	0	0	0
Start Conversion command. The registers are not updated with EEPROM values. SDIO and SDO are enabled as DSP outputs.	8 hex	1	0	0	0
Start Conversion command. The registers are updated with EEPROM values. SDIO and SDO are enabled as DSP outputs.	A hex	1	0	1	0
Start Conversion command. The registers are not updated with EEPROM values. SDIO and SDO are disabled.	C hex	1	1	0	0
Start Conversion command. The registers are updated with EEPROM values. SDIO and SDO are disabled.	E hex	1	1	1	0
Reserved	3, 5, 6, 7, 9, B, D, F hex	-	-	-	-

Table 5. DSP Calibration Coefficient Registers

COEFFICIENT	REGISTER ADDRESS	FUNCTION	RANGE	FORMAT
Gain	1	Gain correction	-32768 to +32767	Integer
G ₁	2	Linear TC gain	-1.0 to +0.99997	Fraction
G ₂	3	Quadratic TC gain	-1.0 to +0.99997	Fraction
Of ₀	4	Offset correction	-1.0 to +0.99997	Fraction
Of ₁	5	Linear TC offset	-1.0 to +0.99997	Fraction
Of ₂	6	Quadratic TC offset	-1.0 to +0.99997	Fraction
Doff	7	Output midscale pedestal	-32768 to +32767	Integer

Writing to the DSP Registers

Command 1 hex writes calibration coefficients from the test system directly into the DSP registers. Tester commands 8 hex and C hex cause the MAX1460 to start a conversion using the calibration coefficients in the registers. This direct use of the registers speeds calibration and compensation because it does not require EEPROM write-access time. Bringing RESET low clears the DSP registers, so the test system should always write to the registers and start a conversion in a single command timing sequence.

As shown in Table 5, seven registers hold the calibration coefficients of the characteristic equation $[D_{OUT} =$ Gain (1+G₁T + G₂T²) (Signal + Of₀ + Of₁T + Of₂T²) + D_{OFF}] implemented by the MAX1460 DSP. All of the registers are 16-bit, two's complement coding format. When a register is interpreted as an integer, the decimal range is from -32768 (8000 hex) to +32767 (7FFF hex). Fractional coefficient values range from -1.0 (8000 hex) to +0.99997 (7FFF hex).

The register at address 0 is called the Configuration Register. It holds the coarse offset, PGA gain, Op Amp Power-Down, temperature-sensor offset, repeat mode, and reserved bits, as shown in Table 6. The functionality of the coarse offset, PGA gain, and temperature-sensor bits are described in the *Analog Front End* section.

The Op Amp Power-Down bit enables the uncommitted op amp when set. The repeat-mode bit is tested by the last instruction of the DSP microcode, and, if set, immediately initiates another conversion cycle. The Maxim reserved bits should not be altered.

EEPROM ADDRESS (HEX)	BIT POSITION	DESCRIPTION
01	0 (LSB)	CO-0 (LSB)
02	1	CO-1 (MSB)
03	2	CO-S (Sign)
04	3	PGA-1 (MSB)
05	4	PGA-0 (LSB)
06	5	Maxim Reserved
07	6	Maxim Reserved
08	7	Op Amp Power-Down
09	8	Maxim Reserved
0A	9	TSO-0 (LSB)
OB	10	TSO-1
0C	11	TSO-2 (MSB)
0D	12	Maxim Reserved
0E	13	Maxim Reserved
0F	14	Maxim Reserved
10	15 (MSB)	Repeat Mode

Table 6. Configuration Register Bitmap

Writing to the Internal EEPROM

The test system writes to the EEPROM with commands 4 hex (Block-Erase the entire EEPROM), 2 hex (Write "1" to a single EEPROM bit) and 0 hex (NOOP). During normal operation (when the TEST pin is low) or when the test system issues instructions A hex or E hex (Start conversion from EEPROM values), the DSP reads the Calibration Coefficients from the EEPROM.

In the normal production flow, determine the calibration coefficients using direct register access. Then load the calibration coefficients into the EEPROM with tester instruction 2 hex. Instruction 4 hex block-erases the EEPROM and is necessary only for a rework or reclaim operation. For each part, the Maxim reserved bits in the Configuration Register should be read before instruction 4 hex is issued, and restored afterwards. The MAX1460 is shipped with its internal EEPROM uninitialized, except for the reserved bits.

The internal 128-bit EEPROM is arranged as eight 16bit words. These eight words are the configuration register and the seven calibration-coefficient values (Table 7).

The MAX1460 EEPROM is bit addressable. The final calibration coefficients must be mapped into the EEPROM locations that are to be set. There is no bitclear instruction. Any EEPROM write operation is necessarily long because the internal charge pump must create and maintain voltages above 20V long enough to cause a reliably permanent change in the memory.

Writing an EEPROM bit requires 6ms, so writing the EEPROM typically requires less than 400ms. Do not decrease the EEPROM write times.

To write an EEPROM bit, the test system must be compliant with the *Command Timing Diagram* shown in Figure 3, performing the following operations:

- 1) Issue command 0 hex, including the EEPROM address field of the bit to be written.
- Issue command 2 hex, with the address field used in step 1. Continuously repeat this command 375 times (6ms).
- 3) Issue command 0 hex, including the EEPROM address field used in steps 1 and 2.

The procedure for using command 4 hex (Block-Erase the EEPROM) is similar. Record the Maxim Reserved bits in the configuration register prior to using this command, and restore them afterwards. The number of Block-Erase operations should not exceed 100.

- 1) Issue command 0 hex.
- 2) Issue command 4 hex. Continuously repeat this command 375 times (6ms).
- 3) Issue command 0 hex.

Test System Interface: Observing the DSP Operation

Test system commands 8 hex and A hex initiate a conversion while allowing the test system to observe the operation of the DSP. To calibrate a unit, the test system must know the digitized temperature and sensor signals, stored in DSP registers 8 and 9, and the calibrated and compensated output stored in DSP register 10. The test system should also verify the EEPROM contents, registers 0–7. All these signals pass through DSP register S during the execution of the instruction ROM microcode. The SDO pin outputs the S register values, and the SDIO pin tells the tester which signal is currently on S.

Table 7. EEPROM Memory Map

				•												
EE Address (hex)	10	0F	0E	0D	0C	0B	0A	09	08	07	06	05	04	03	02	01
Contents	MSE	3						Config	uration							LSB
EE Address (hex)	20	1F	1E	1D	1C	1B	1A	19	18	17	16	15	14	13	12	11
Contents	MSE	3						Ga	ain							LSB
				1				i	1			1				
EE Address (hex)	30	2F	2E	2D	2C	2B	2A	29	28	27	26	25	24	23	22	21
Contents	MSE	3						G	à1							LSB
EE Address (hex)	40	ЗF	ЗE	3D	ЗC	3B	ЗA	39	38	37	36	35	34	33	32	31
Contents	MSE	3						G	2							LSB
							-									
EE Address (hex)	50	4F	4E	4D	4C	4B	4A	49	48	47	46	45	44	43	42	41
Contents	MSE	3						0	fo							LSB
EE Address (hex)	60	5F	5E	5D	5C	5B	5A	59	58	57	56	55	54	53	52	51
Contents	MSE	3						0	lf1							LSB
EE Address (hex)	70	6F	6E	6D	6C	6B	6A	69	68	67	66	65	64	63	62	61
Contents	MSE	3						0	lf ₂							LSB
EE Address (hex)	00	7F	7E	7D	7C	7B	7A	79	78	77	76	75	74	73	72	71
Contents	MSE	3						D _C	DFF							LSB
L	1															

Table 8. Subset of DSP Instruction

INSTRUCTION CODE (PS) (HEX)	PROGRAM COUNTER (P) (HEX)	S REGISTER VALUE				
D0	66 or 6C	Register 0—Configuration				
D1	47	Register 1—Gain				
D2	11	Register 2—G ₁				
D3	2E	Register 3—G ₂				
D4	38	Register 4—Of ₀				
D5	03	Register 5—Of1				
D6	22	Register 6—Of ₂				
D7	56	Register 7—DOFF				
D8	01	Register 8—Temperature Signal				
D9	3B	Register 9—Sensor Signal				
EA	65 or 6B	Register 10—Compensated Output D				

There are three internal DSP registers that are directly observable on the SDIO and SDO pins:

- S: 16-bit DSP Scratch or Accumulator register, containing the result of the execution of the current microcode instruction.
- P: 8-bit DSP Program Pointer register, which holds the address of the instruction ROM microcode.
- PS: 8-bit DSP Program Store register. PS is the instruction that the DSP is currently executing. PS is the instruction ROM data at address P.

The DSP instructions relevant to the test system are listed in Table 8.

After the test system sends the Start Conversion commands 8 hex or A hex, SDIO and SDO are both enabled as MAX1460 serial outputs. The test system should disable (high impedance) its SDIO driver to avoid a bus conflict at this time so that the MAX1460 can drive the pin. After the DSP executes each one of the microcode instructions, the contents of the registers S, P, and PS are output in a serial format (Figure 4).

A new DSP instruction and a new state of the S, P, and PS registers are delivered every 16n + 9 clock cycles, where n = 0, 1, 2... after the Start Conversion command completes. The tester should latch the SDIO and SDO



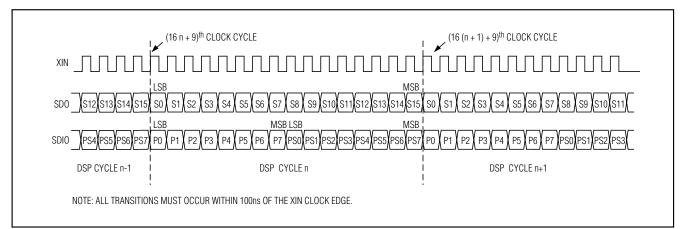


Figure 4. DSP Serial Output Timing Diagram

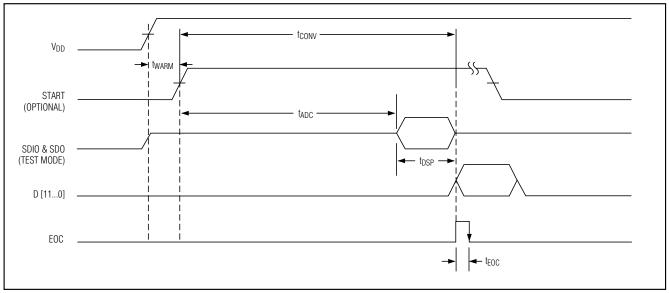


Figure 5. MAX1460 Conversion Timing

bits on the falling edge of the XIN clock signal. When the P and PS registers in Table 8 appear on SDIO, the tester should save the corresponding SDO data.

The conversion timing of the MAX1460 is shown in Figure 5 and Table 9. In the figure, the conversion is initiated by a rising transition on the START pin. Equivalently, conversion can be initiated in TEST mode after completion of tester commands 8 hex or A hex, or reinitiated by the state of the Repeat Mode bit in the configuration register. After a conversion is initiated, the 16-bit ADC digitizes the temperature and sensor signals during tADC. Then, the DSP executes the

instruction ROM microcode during tDSP. In TEST mode, and during tDSP, SDIO and SDO outputs carry useful information. At 130,586 clock cycles after the Start Conversion command is received, the LSB of the S and P DSP registers is available on SDO and SDIO. The last DSP instruction is D0 hex. The tester can now start a new communication sequence by lowering the RESET pin for at least 16 clock cycles, and then resume driving SDIO. SDIO becomes high impedance when RESET is low.

M/XI/M

MAX1460

MIN

35

130.585

Low-Power, 16-Bit Smart ADC

Table 9. WAX 1400 COnversion Thin				
PARAMETER	SYMBOL			
Sensor Warm-Up Time	twarm			
ADC Time	tADC			
DSP Time	tDSP			
EOC Pulse Width	tEOC			
Conversion Time	tCONV			

Table 9 MAX1/60 Conversion Ti ing

tDSP	3,220	3,364	XIN clk cycles
tEOC	8	8	XIN clk cycles
tCONV	133,805	133,949	XIN clk cycles

Applications Information

Calibration and Compensation Procedure Perform fine calibration by characterizing the sensor/

MAX1460 pair using the test system and then finding the calibration coefficients Gain, G₁, G₂, Of₀, Of₁, and Of₂ using the equations below. This simple fine-calibration procedure requires three temperatures, denoted A, B, and C, and two sensor excitations, named S and L for small and large. Thus, there are six data points (AS, AL, BS, BL, CS, and CL); six unknown calibration coefficients; and six versions of the characteristic equation, in the form:

Equation (1)

$$D_{L} - D_{OFF} = Gain \left(1 + G_{1}T_{C} + G_{2}T_{C}^{2}\right)$$

(Signal_{CL} + Of₀ + Of₁T_C + Of₂T_C²)

where DL, DS, and DOFF are determined by the end product specification. D_I is the desired MAX1460 output corresponding to the L sensor excitation; Ds is the desired MAX1460 output corresponding to the S sensor excitation; DOFF is the desired midscale output; SignalCL is the digitized sensor reading at temperature C with the L sensor excitation applied; and T_C is the digitized temperature reading at temperature C.

Unstable digitized temperature readings indicate that thermal equilibrium has not been achieved, necessitating increased soak times or a better thermal control. Averaging many readings from the MAX1460 will help filter out AC variations in the sensor excitation and oven temperature.

Begin calibration by soaking the sensor and the MAX1460 pair at the first temperature, A, and apply the L excitation to the sensor. Start a conversion and record the digitized temperature TA and the digitized signal SignalAL. Apply the S sensor excitation, and record the digitized signal SignalAS. Repeat this procedure for temperatures B and C, recording TB, SignalBL, Signal_{BS}, T_C, Signal_{CL}, and Signal_{CS}.

The AL and As versions of equation 1 may be ratioed to obtain:

MAX

130.585

UNITS

ms

XIN clk cycles

Equation (2a)

$$\frac{\text{Signal}_{AL} - x \cdot \text{Signal}_{AS}}{1 - x} + \text{Of}_0 + \text{Of}_1\text{T}_A + \text{Of}_2\text{T}_A^2 = 0$$

Equation (2b)

Similarly,

$$\frac{\text{Signal}_{\text{BL}} - x \cdot \text{Signal}_{\text{BS}}}{1 - x} + \text{Of}_0 + \text{Of}_1\text{T}_{\text{B}} + \text{Of}_2\text{T}_{\text{B}}^2 = 0$$

Equation (2c)

$$\frac{\text{Signal}_{\text{CL}} - x \cdot \text{Signal}_{\text{CS}}}{1 - x} + \text{Of}_0 + \text{Of}_1\text{T}_{\text{C}} + \text{Of}_2\text{T}_{\text{C}}^2 = 0$$

where

Equation (3)

$$x = \frac{D_L - D_{OFF}}{D_S - D_{OFF}}$$

Х

Equations 2a, 2b, and 2c form a system of three linear equations, with three unknowns, Of₀, Of₁, and Of₂. Solve for Of₀, Of₁, and Of₂.

The small sensor excitation versions of Equation 1 can be ratioed to obtain:

Equation (4a)

$$(Y_{CS} - Y_{AS}) + G_1 (T_A Y_{CS} - T_C Y_{AS}) + G_2 (T_A^2 Y_{CS} - T_C^2 Y_{AS}) = 0$$

Equation (4b)

$$(Y_{CS} - Y_{BS}) + G_1 (T_B Y_{CS} - T_C Y_{BS}) + G_2 (T_B^2 Y_{CS} - T_C^2 Y_{BS}) = 0$$





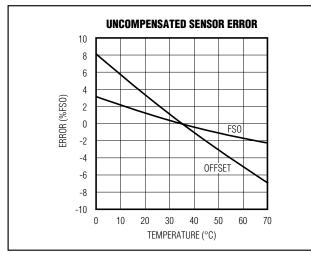


Figure 6. Sensor Characteristics Before Compensation

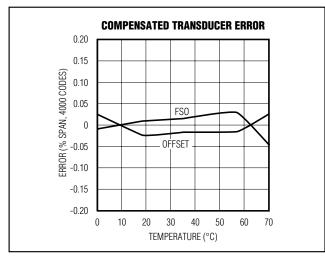


Figure 7. Compensated Sensor/MAX1460 Pair

where:

Equation (5a)

$$Y_{AS} = \frac{D_S - D_{OFF}}{\text{Signal}_{AS} + Of_0 + Of_1T_A + Of_2T_A^2}$$

Equation (5b)

$$f_{BS} = \frac{D_S - D_{OFF}}{Signal_{BS} + Of_0 + Of_1T_B + Of_2T_B^2}$$

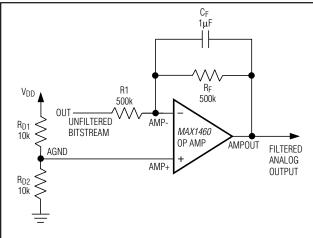


Figure 8. Filtering the Output DAC

Equation (5c)

$$Y_{CS} = \frac{D_S - D_{OFF}}{Signal_{CS} + Of_0 + Of_1T_C + Of_2T_C^2}$$

Equations 4a and 4b form a system of two linear equations and two unknowns, G_1 and G_2 . Solve for G_1 and G_2 . Equation 1 can now be readily solved for the last unknown, Gain.

Arithmetic manipulation can magnify measurement errors and noise. Quantization of the calibration coefficients is another reason to consider adjusting the Gain and D_{OFF} coefficients. To do this, load the MAX1460 registers with the calculated coefficients Gain, G₁, G₂, Of₀, Of₁, Of₂, and D_{OFF}. Assuming the oven is still at temperature C and the S sensor excitation is still applied, measure the output D_{CS}. Change to the L sensor excitation, and measure D_{CL}. Compute the new Gain coefficient using equation 6. Remeasure D_{CL}, and compute the new D_{OFF} coefficient, given by equation 7.

Equation (6)

$$GAIN_{new} = Gain \frac{D_L - D_S}{D_{CL} - D_{CS}}$$

Equation (7)

The final calibration coefficients may now be written into the MAX1460 EEPROM. The unit is now ready for final test.

/N/IXI/N

This algorithm minimizes the error directly at the six test conditions, AS, AL, BS, BL, CS, and CL. Space the temperatures A, B, and C widely to minimize the signalto-noise ratio of the measurement. If there is a large error remaining in the finished product, move the calibration temperatures closer to the peak error temperatures. Similarly, full-scale sensor excitation may not be the best calibration condition if the sensor has nonlinearities. Move S and L away from full scale.

Figure 6 shows the characteristics of an individual Lucas-NovaSensor model NPH8-100-EH, 0 to 15psig, silicon pressure sensor. Figure 7 shows the result of the compensated sensor/MAX1460 pair.

Using the Compensated Sensor/MAX1460 Pair

After calibration and removal from the test system, the MAX1460 and the sensor form a mated pair. The START pin can be connected to V_{DD} or left unconnected if the sensor does not require a significant warm-up time. Now operation is simple: just apply power and latch the parallel output D when EOC falls. Temperature is digitized during the first half of tADC, so the MAX1460 provides a minimum sensor warm-up time of 35ms. Using a 2MHz resonator, the conversion time t_{CONV} is nominally 67ms. If the Repeat Mode bit is set, conversions repeat at a rate of 15Hz.

If the sensor requires more than 35ms of warm-up time, the START pin may be used to initiate conversion (Figure 5). If the Repeat Mode bit is set, START should remain high. If the Repeat Mode bit is reset, START may be used to externally control the conversion rate of the MAX1460. After the 12-bit parallel output D is latched, end the conversion by taking START low for at least one clock cycle.

The output DAC converts the parallel digital output into a serial bitstream on OUT. A simple external lowpass filter, using the MAX1460 op amp, converts the OUT bitstream into a ratiometric analog voltage (Figure 8). The filter shown is an inverting configuration, but the Gain and DOFF coefficients of the characteristic equation can be adjusted to obtain either polarity. If the <u>op</u> <u>amp is not used</u>, it can be powered down using the <u>Op</u> <u>Amp Power-Down bit in the configuration register</u>.

The MAX1460 requires a minimum of external components:

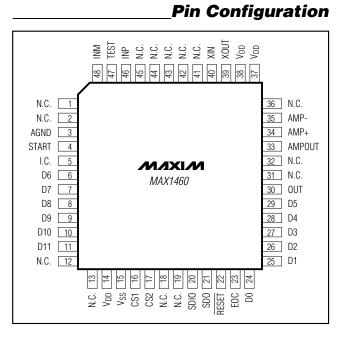
- One power-supply bypass capacitor (C1) from V_{DD} to V_{SS}.
- One 2MHz ceramic resonator (X1).
- Two 10kΩ resistors for the AGND pin.
- If an analog output is desired, two 500kΩ resistors and a 1µF capacitor are needed for filtering.

MAX1460 Evaluation/ _____Development Kit

The MAX1460 evaluation kit (EV kit) speeds the development of MAX1460-based transducer prototypes and test systems. First-time users of the MAX1460 are strongly encouraged to use this kit, which includes:

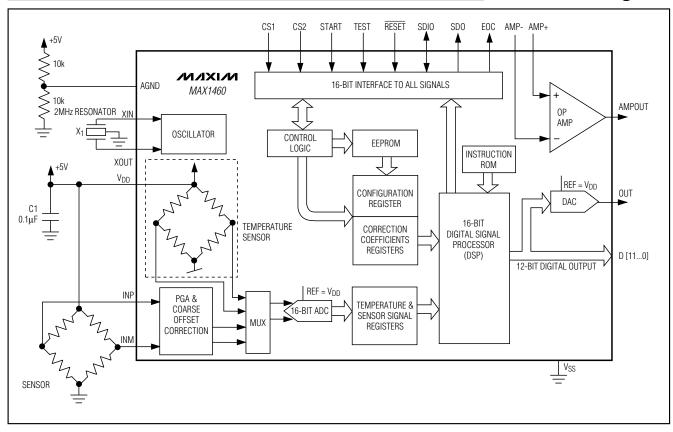
- 1) Evaluation board, with a MAX1460 sample and a silicon pressure sensor, ready for customer evaluation.
- 2) Interface board that must be connected to a PC parallel port.
- MAX1460 communication/compensation software (Windows compatible), which enables programming of the MAX1460 one module at a time.
- 4) Detailed Design/Applications manual, developed for sensor-test engineers.

The evaluation kit order number is MAX1460EVKIT.





16



Functional Diagram

MAX1460

Chip Information

TRANSISTOR COUNT: 59,855 SUBSTRATE CONNECTED TO V_{SS}

NOTES

M/XI/M

NOTES

NOTES

Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.

20	Maxim Integrated Products, 120 San Gabriel Drive, Sunnyvale, CA 94086 408-737-7600
----	--

© 1999 Maxim Integrated Products Printed USA MAXIM is a registered trademark of Maxim Integrated Products.

SUNSTAR商斯达实业集团是集研发、生产、工程、销售、代理经销 、技术咨询、信息服务等为一体的高 科技企业,是专业高科技电子产品生产厂家,是具有10多年历史的专业电子元器件供应商,是中国最早和 最大的仓储式连锁规模经营大型综合电子零部件代理分销商之一,是一家专业代理和分銷世界各大品牌IC 芯片和電子元器件的连锁经营綜合性国际公司。在香港、北京、深圳、上海、西安、成都等全国主要电子 市场设有直属分公司和产品展示展销窗口门市部专卖店及代理分销商,已在全国范围内建成强大统一的供 货和代理分销网络。 我们专业代理经销、开发生产电子元器件、集成电路、传感器、微波光电元器件、工 控机/DOC/DOM电子盘、专用电路、单片机开发、MCU/DSP/ARM/FPGA软件硬件、二极管、三极管、模 块等,是您可靠的一站式现货配套供应商、方案提供商、部件功能模块开发配套商。**专业以现代信息产业** (计算机、通讯及传感器)三大支柱之一的传感器为主营业务,专业经营各类传感器的代理、销售生产、 网络信息、科技图书资料及配套产品设计、工程开发。我们的专业网站——中国传感器科技信息网(全球 传感器数据库)www.SENSOR-IC.COM 服务于全球高科技生产商及贸易商,为企业科技产品开发提供技 术交流平台。欢迎各厂商互通有无、交换信息、交换链接、发布寻求代理信息。欢迎国外高科技传感器、 **变送器、执行器、自动控制产品厂商介绍产品到 中国,共同开拓市场**。本网站是关于各种传感器-变送器-仪器仪表及工业自动化大型专业网站,深入到工业控制、系统工程计 测计量、自动化、安防报警、消费电 子等众多领域,把最新的传感器-变送器-仪器仪表买卖信息,最新技术供求,最新采购商,行业动态,发展方 向,最新的技术应用和市场资讯及时的传递给广大科技开发、科学研究、产品设计人员。本网站已成功为 石油、化工、电力、医药、生物、航空、航天、国防、能源、冶金、电子、工业、农业、交通、汽车、矿 山、煤炭、纺织、信息、通信、IT、安防、环保、印刷、科研、气象、仪器仪表等领域从事科学研究、产 品设计、开发、生产制造的科技人员、管理人员 、和采购人员提供满意服务。 我公司专业开发生产、代 理、经销、销售各种传感器、变送器、敏感元器件、开关、执行器、仪器仪表、自动化控制系统: 专门从 事设计、生产、销售各种传感器、变送器、各种测控仪表、热工仪表、现场控制器、计算机控制系统、数 据采集系统、各类环境监控系统、专用控制系统应用软件以及嵌入式系统开发及应用等工作。如热敏电阻、 压敏电阻、温度传感器、温度变送器、湿度传感器、 湿度变送器、气体传感器、 气体变送器、压力传感 器、 压力变送、称重传感器、物(液)位传感器、物(液)位变送器、流量传感器、 流量变送器、电流 (压)传感器、溶氧传感器、霍尔传感器 、图像传感器、超声波传感器、位移传感器、速度传感器、加速 度传感器、扭距传感器、红外传感器、紫外传感器、 火焰传感器、激光传感器、振动传感器、轴角传感器、 光电传感器、接近传感器、干簧管传感器、继电器传感器、微型电泵、磁敏(阻)传感器 、压力开关、接 近开关、光电开关、色标传感器、光纤传感器、齿轮测速传感器、 时间继电器、计数器、计米器、温控仪、 固态继电器、调压模块、电磁铁、电压表、电流表等特殊传感器 。 同时承接传感器应用电路、产品设计 和自动化工程项目。

更多产品请看本公司产品专用销售网站: 商斯达中国传感器科技信息网: http://www.sensor-ic.com/ 商斯达工控安防网: http://www.pc-ps.net/ 商斯达电子 元器件网: http://www.sunstare.com/ 商斯达微波光电产品网:HTTP://www.rfoe.net/ 商斯达消费电子产品网://www.icasic.com/ 商斯达军工产品网:http://www.junpinic.com/ 商斯达实业科技产品网://www.sunstars.cn/传感器销售热线: 地址: 深圳市福田区福华路福庆街鸿图大厦 1602 室 电话: 0755-83607652 83376489 83376549 83370250 83370251 82500323 传真: 0755-83376182 (0) 13902971329 MSN: SUNS8888@hotmail.com 邮编: 518033 E-mail:szss20@163.com QQ: 195847376 深圳赛格展销部: 深圳华强北路赛格电子市场 2583 号 电话: 0755-83665529 25059422 技术支持: 0755-83394033 13501568376 欢迎索取免费详细资料、设计指南和光盘 ; 产品凡多,未能尽录,欢迎来电查询。 北京分公司:北京海淀区知春路 132 号中发电子大厦 3097 号 TEL: 010-81159046 82615020 13501189838 FAX: 010-62543996 上海分公司:上海市北京东路 668 号上海賽格电子市场 D125 号 TEL: 021-28311762 56703037 13701955389 FAX: 021-56703037 西安分公司:西安高新开发区 20 所(中国电子科技集团导航技术研究所) 西安劳动南路 88 号电子商城二楼 D23 号 TEL: 029-81022619 13072977981 FAX:029-88789382